

High-Voltage, High-Current Darlington Transistor Arrays

GENERAL DESCRIPTION

The XR-2011/2012/2013/2014 are high-voltage, high-current Darlington transistor arrays consisting of seven silicon NPN Darlington pairs on a common monolithic substrate. All units feature open collector outputs and integral protection diodes for driving inductive loads. Peak inrush currents of up to 750 mA are allowed, which makes the arrays ideal for driving tungsten filament lamps. The outputs may be paralleled to achieve higher load current capability although each driver has a maximum continuous collector current rating of 600 mA. The arrays are directly price competitive with discrete transistor alternatives.

FEATURES

- Peak Inrush Current Capability of 750 mA
- Internal Protection Diodes for Driving Inductive Loads
- Excellent Noise Immunity
- Direct Compatibility with Most Logic Families
- Opposing Pin Configuration Eases Circuit Board Layout

APPLICATIONS

- Relay Drive
- High Current Logic Driver

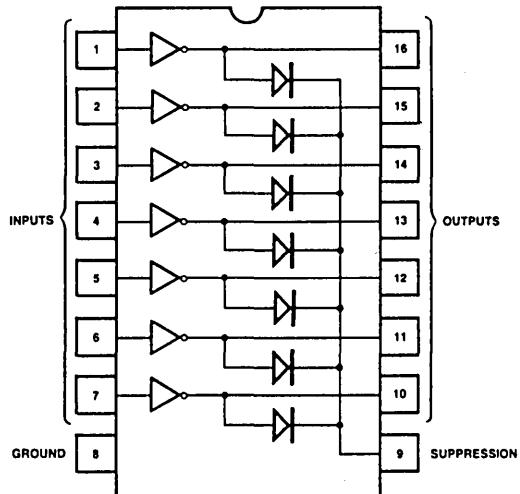
ABSOLUTE MAXIMUM RATINGS $T_A = 25^\circ\text{C}$

Output Voltage, V_{CE}	50V
Input Voltage, V_{IN}	30V
Continuous Collector Current, I_C (Each Driver)	600 mA
Continuous Base Current, I_B (Each Driver)	25 mA
Power Dissipation, P_D (Each Driver) (Total Package)	1.0 W See graph
Derate Above 25°C	16.67 mW/ $^\circ\text{C}$
Storage Temperature Range	-55 $^\circ\text{C}$ to +150 $^\circ\text{C}$

ORDERING INFORMATION

Part Number	Package Type	Operating Temperature
XR-2011 CN	Ceramic	0 $^\circ\text{C}$ to +70 $^\circ\text{C}$
XR-2012 CN	Ceramic	0 $^\circ\text{C}$ to +70 $^\circ\text{C}$
XR-2013 CN	Ceramic	0 $^\circ\text{C}$ to +70 $^\circ\text{C}$
XR-2014 CN	Ceramic	0 $^\circ\text{C}$ to +70 $^\circ\text{C}$

FUNCTIONAL BLOCK DIAGRAM



SYSTEM DESCRIPTION

The XR-2011 device is a general purpose array to be used with bipolar digital logic (with external current limiting), or with CMOS or PMOS directly. Output pins opposite input pins facilitates circuit board layout.

The XR-2012 was specifically designed to interface with 14 to 25 volt PMOS devices. The input current is limited to a safe value by a Zener diode and resistor in series.

A 2.7 k Ω series base resistor to each Darlington pair in the XR-2013 permits operation directly with CMOS or TTL operating with a 5 volt supply. Interface requirements beyond the scope of standard logic buffers are easily handled by the XR-2013.

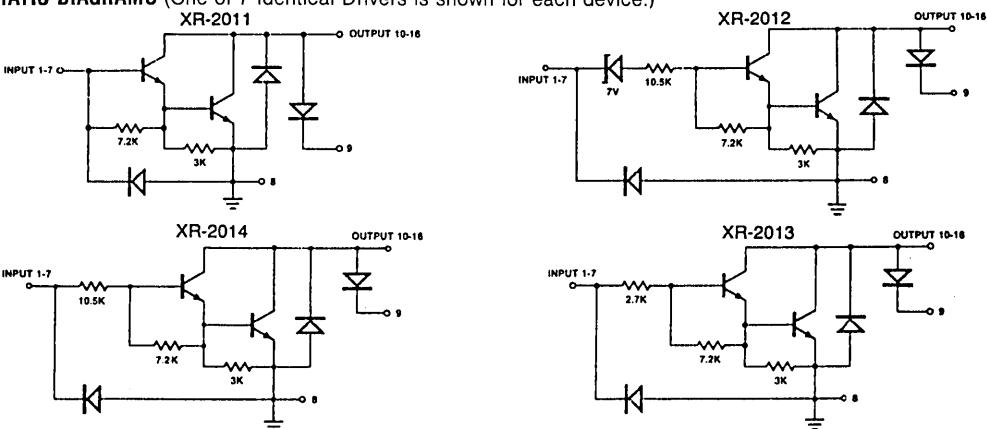
The XR-2014 requires less input current than the XR-2013 and the input voltage is less than that required by the XR-2012. The XR-2014 has a 10.5 k Ω series input resistor, permitting operation directly from PMOS or CMOS outputs using supply voltages of 6 to 15 volts.

XR-2011/12/13/14

ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

SYMBOL	PARAMETERS	LIMITS			UNITS	CONDITIONS
		MIN	TYP	MAX		
I_{CEX}	Output Leakage Current XR-2012 XR-2014			100 500 500	μA	$V_{CE} = 50 \text{ V}, T_A = 70^\circ\text{C}$ $V_{CE} = 50 \text{ V}, T_A = 70^\circ\text{C}, V_{IN} = 6 \text{ V}$ $V_{CE} = 50 \text{ V}, T_A = 70^\circ\text{C}, V_{IN} = 1 \text{ V}$
V_{CE}	Collector-Emitter Saturation Voltage		1.7 1.3 1.1	1.9 1.6 1.3	V	$I_C = 500\text{mA}, I_B = 600\mu\text{A}$ $I_C = 350\text{mA}, I_B = 500\mu\text{A}$ $I_C = 200\text{mA}, I_B = 350\mu\text{A}$
I_{IN}	Input Current (on) XR-2012 XR-2013 XR-2014		0.82 0.93 0.35 1.0	1.25 1.35 0.5 1.45	mA	$V_{IN} = 17\text{V}$ $V_{IN} = 3.85\text{V}$ $V_{IN} = 5\text{V}$ $V_{IN} = 12\text{V}$
I_{IN}	Input Current (off)	50	65		μA	$I_C = 500\mu\text{A}, T_A = 70^\circ\text{C}$
V_{IN}	Input Voltage XR-2012 XR-2013 XR-2014			17 2.7 3.0 3.5 7.0 8.0 9.5	V	$V_{CE} = 2 \text{ V}, I_C = 500\text{mA}$ $V_{CE} = 2 \text{ V}, I_C = 250\text{mA}$ $V_{CE} = 2 \text{ V}, I_C = 300\text{mA}$ $V_{CE} = 2 \text{ V}, I_C = 500\text{mA}$ $V_{CE} = 2 \text{ V}, I_C = 275\text{mA}$ $V_{CE} = 2 \text{ V}, I_C = 350\text{mA}$ $V_{CE} = 2 \text{ V}, I_C = 500\text{mA}$
h_{FE}	D-C Forward Current Transfer Ratio XR-2011	1000				$V_{CE} = 2 \text{ V}, I_C = 350\text{mA}$
C_{IN}	Input Capacitance		15	30	pF	
I_R	Clamp Diode Leakage Current			50	μA	$VR = 50\text{V}$
V_F	Clamp Diode Forward Voltage		2.1	2.5	V	$I_F = 500\text{mA}$
t_{PLH}	Turn-On Delay		0.25	1.0	μs	0.5 E_{IN} to 0.5 E_{OUT}
t_{PHL}	Turn-Off Delay		0.25	1.0	μs	0.5 E_{IN} to 0.5 E_{OUT}

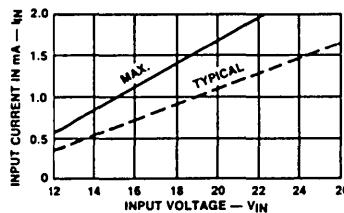
SCHEMATIC DIAGRAMS (One of 7 Identical Drivers is shown for each device.)



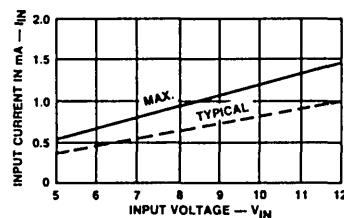
XR-2011/12/13/14

CHARACTERISTIC CURVES

(a) XR-2012



(b) XR-2014



(c) XR-2013

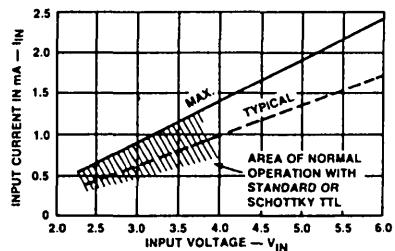


Figure 1. Input Current as a Function of Input Voltages

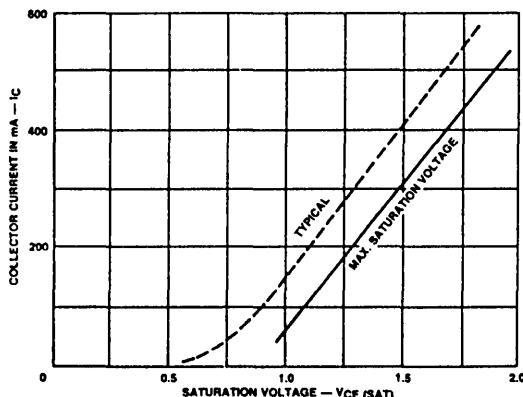


Figure 2. Collector Current as a Function of Saturation Voltage

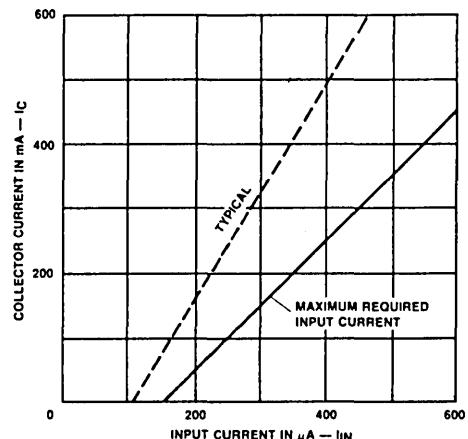


Figure 3. Collector Current as a Function of Input Current

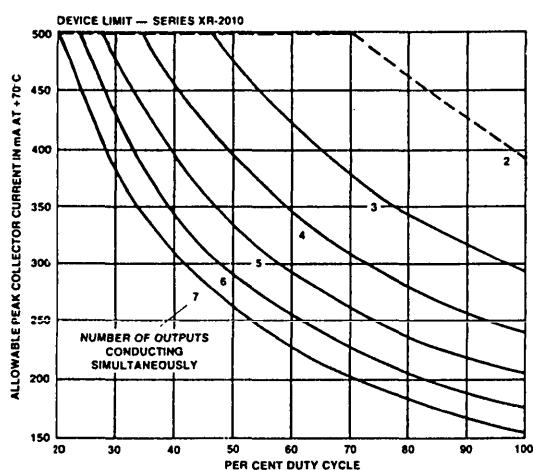


Figure 4. Peak Collector Current as a Function of Duty Cycle and Number of Outputs

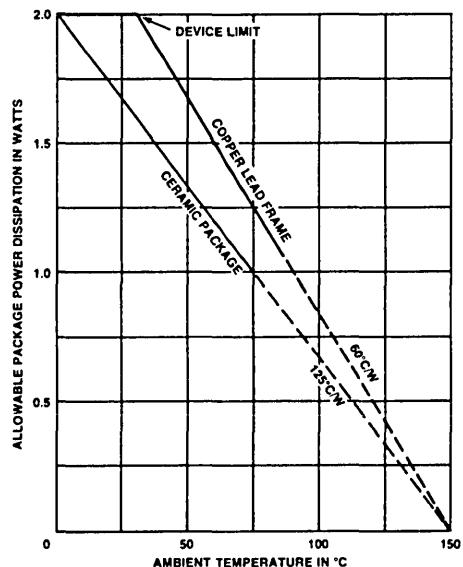


Figure 5. Allowable Average Power Dissipation as a Function of Ambient Temperature

XR-2011/12/13/14

TYPICAL APPLICATIONS

XR-2012

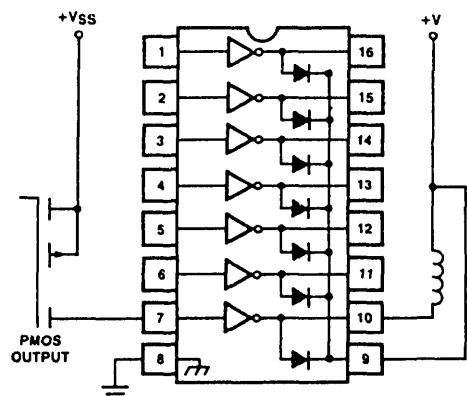


Figure 6. PMOS to Load

XR-2013

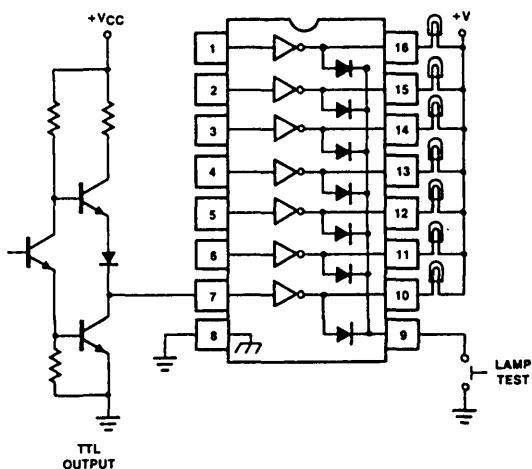


Figure 7. TTL to Load

XR-2014

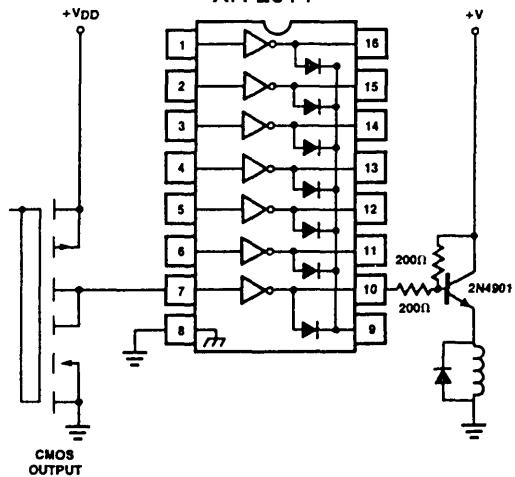


Figure 8. Buffer for Higher Current Loads

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XR-2013

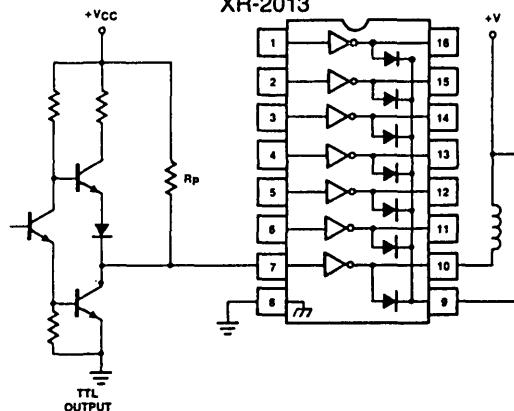


Figure 9. Use of Pull-up Resistors to Increase Drive Current